

Search Notes

Application/Control No.

10/779,698

Examiner

Biju Chandran

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2835

SEARCHED

Class	Subclass	Date	Examiner
361	705	11/2/2005	BIC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
see search history		